

Search Notes (continued)

Application/Control No.

10/698,317

Examiner

Patricia T. Nguyen

Applicant(s)/Patent under
Reexamination

MUKHERJEE ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	253	4/26/2005	PN
333	214		
336	200		
	220		
330	165		
	188		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR